

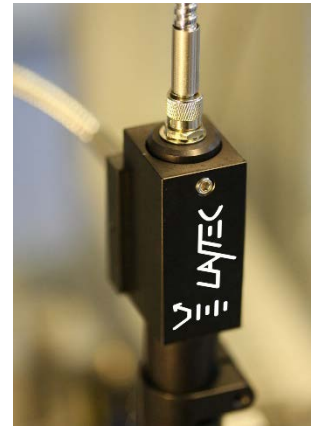
## LayTec's 2000<sup>th</sup> in-situ tool delivered to Compound Semiconductor Centre (Cardiff, UK)

LayTec is proud to deliver its 2000<sup>th</sup> in-situ metrology system since its foundation in 1999! An EpiTT with the figure 2000 in its serial number has been shipped to Compound Semiconductor Centre (CSC) - a joint venture between compound semiconductor specialists IQE and Cardiff University.

CSC works on providing a complete capability value chain from high-end R&D through product and process innovation to high value, large-scale manufacturing. According to Dr. Wyn Meredith, Director of CSC, "This EpiTT and other LayTec systems already installed in our labs provide unrivalled precision and sophisticated analysis algorithms, which is crucial for process optimization in semiconductor manufacturing environment."

LayTec's founder and CEO Dr. Thomas Zettler commented: "It is significant that our 2000<sup>th</sup> in-situ tool is delivered to a research institution with a strong connection to industry. LayTec has always set a great value on cooperating with both industry and R&D. Until now, we have equipped hundreds of customers worldwide with state-of-the-art metrology, mainly in the field of LED and laser production. In the last few years we also entered the PV, display and advanced silicon markets. Meanwhile, our product portfolio covers all areas of process monitoring: in-situ, in-line, lab-line and map-line metrology. Due to this market diversification, we believe to deliver the next thousand tools much faster than before. We are proud that our tools make the related industries more effective and more productive."

Learn more at [www.laytec.de](http://www.laytec.de)!



EpiTT – LayTec's workhorse for MOCVD mass production